Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/731,754	COUCHEY ET AL.		
Examiner	Art Unit		
John Q. Nguyen	3654		

SEARCHED					
Class	Subclass	Date	Examiner		
Previous	Search updated	9/27/2006	JN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	ference text arch	9/27/2006	JN	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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